Influence of oxygen vacancies on the electronic structure of HfO$_2$ films


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We investigated the unoccupied part of the electronic structure of the oxygen-deficient hafnium oxide (HfO$_{1.8}$) using soft x-ray absorption spectroscopy at O K and Hf N$_3$ edges. Band-tail states beneath the unoccupied Hf 5$d$ band are observed in the O K-edge spectra. Combined with ultraviolet photoemission spectrum, this indicates the non-negligible occupation of the Hf 5$d$ state. However, Hf N$_3$-edge magnetic circular dichroism spectrum reveals the absence of a long-range ferromagnetic spin order in the oxide. Thus, the small amount of $d$ electron gained by the vacancy formation does not show intersite correlation, contrary to a recent paper [M. Venkatesan et al., Nature 430, 630 (2004)].

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I. INTRODUCTION

An oxygen vacancy in a large band-gap oxide changes the electrical characteristics by forming defect states inside the band gap. Depending on the position and density of the defect energy levels, the chemical potential of the oxide—frequently identified with the Fermi level ($E_F$)—changes as in the case of doping with other atomic species. Hence, the characterization of the defect level is a prerequisite for understanding the electron transfer across the oxide-semiconductor interface, because the energy barrier height at the interface depends on $E_F$ of the oxide. With regard to hafnium oxide, the energy position of this defect level has been estimated theoretically and experimentally to be above the middle of the band gap, so $E_F$ is shifted upward in the presence of oxygen vacancies. Since $E_F$ is determined from the charge neutrality condition, it is largely influenced by the detailed density of states (DOS) near the band gap. In this case, the intensity of the features near the conduction band (CB) is expected to be higher than those near the valence band (VB).

Recent density-functional-theoretical (DFT) studies have revealed that the defect state is the localized Hf $d$ state. The nonzero occupation in the Hf $d$ shell is very natural, because the Hf atom no longer donates electrons to the adjacent vacant sites. If an intersite correlation existed between the $d$ electrons, even a long-range correlation in the electronic configuration of each site might emerge. Surprisingly, room-temperature long-range ferromagnetism (FM) was recently reported in an oxygen-deficient Hf oxide film, although an experimental counterevidence shows the absence of FM. Since the measured magnetization is the macroscopic quantity, it might significantly depend on the purity of the sample. Furthermore, recent DFT studies have revealed that FM can be induced by a hafnium vacancy rather than an oxygen vacancy, while the oxygen vacancy can at the most yield paramagnetism. Thus, it is important to investigate the possible long-range spin order in the oxygen-deficient HfO$_{1.8}$ from a microscopic point of view, in that the microscopic quantities such as the spin or angular momentum drive the macroscopic properties, i.e., the magnetization. Since these microscopic values are determined from the electronic structure, the study on the local electron configurations of each atomic species will provide the information that is not influenced by a macroscopic deformation (domain interaction, dislocation, etc.) or an intervention of impurities.

Therefore, in this paper, we focus on electron redistribution and the possible long-range spin order in the presence of an oxygen vacancy in Hf oxide by studying its electronic structure. To investigate the unoccupied electronic structure of the Hf $d$ states, we performed an x-ray absorption spectroscopy (XAS) study on the HfO$_{1.8}$ film. Since XAS reflects a transition probability from a spatially localized core level to the unoccupied levels, it is sensitive to the unoccupied states originating from the atoms near the photon-absorbing atom. Further, owing to the “locality” that allows transitions irrespective of momentum transfer, it reflects the momentum-averaged electronic structure that would be equivalent to the partial density of states (PDOS) in the absence of an electron correlation. We can choose the photon absorber by tuning the photon energy range to any of the core-level energies of each atomic species. Using the photon energy range $h\nu \sim 530$ eV, we can measure O K-edge ($1s - 2p$) absorption to investigate the O 2p PDOS. Since parts of O 2p wave functions are hybridized with Hf 5$d$ wave functions, O K-edge XAS also shows the unoccupied Hf 5$d$ energy levels that are hybridized with the O wave functions. This implies that an Hf $d$-electron state that stays near the vacant site is hardly observed in O K-edge XAS. The situation is described in Fig. 1. The dashed circle near an oxygen atom roughly indicates the probing area of O K-edge XAS. However, at the Hf N$_3$ edge ($4p_{3/2}, h\nu \sim 380$ eV), we can detect all of the Hf 5$d$ wave functions whether the $d$-electron state is localized near the vacancy or hybridized with the surrounding oxygen atoms (see Fig. 1). Although the obtained spectra become complex due to the on-site core-hole effect, this measurement directly shows the $d$ occupation at the Hf site.
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II. EXPERIMENTAL DETAILS

The O K-edge and Hf N\textsubscript{3}-edge XASs of the oxygen-deficient Hf oxide were performed at the 2A EPU6 beamline of the Pohang Light Source (PLS). In order to determine the existence of a long-range FM spin order, we also performed magnetic circular dichroism (MCD) measurements. The MCD spectrum is the difference between two XAS spectra measured using external magnetic fields of mutually opposite directions. Here, a circularly polarized photon should be used, since the relative orientation of its chirality with respect to the direction of the spin moment determines the preference of pumped spins. To align the spin direction, a magnetic field exceeding the coercivity field of the system should be applied. The oxygen-deficient film of \( \approx 20 \) Å was fabricated onto a Hf-etched Si(100) substrate with a 3 Hz pulsed Nd:YAG laser at a substrate temperature of 700 °C. The base pressure of the growth chamber was \( 1 \times 10^{-8} \) Torr and no oxygen flow was supplied during the film growth. The oxygen concentration deduced from the intensity ratio of O 1s/Hf 4f core levels in the \textit{in situ} x-ray photoemission spectroscopy (XPS) spectra was approximately 1.8 (i.e., 10% oxygen deficiency). An approximate estimation of the Hf valence leads to \( \sim \text{Hf}^{3.6} \), i.e., a composite of 60% of Hf\textsuperscript{4+} and 40% Hf\textsuperscript{3+}.

III. RESULTS AND DISCUSSIONS

Figure 2 shows the O K-edge XAS spectrum with circularly polarized photons for HfO\textsubscript{1.8}. The overall features of the spectrum are similar to those of the previous experiments for HfO\textsubscript{2} (Refs. 18–20) as well as the theoretical band calculations for the unoccupied states.\textsuperscript{10,21–23} The spectrum was analyzed using a model cluster calculation with full atomic multiplets,\textsuperscript{24} assuming the composite \([d^5(60\%) \oplus d^4(40\%)]\) in a perfect monoclinic crystal structure. As already noted, XAS is relevant to the interactions between the near atoms only; therefore, the single cluster model with an Hf atom and its nearest oxygen atoms is sufficient to simulate the XAS spectra. Though the Hf oxide film is in an amorphous phase, the local bonds can be assumed to be similar to those of the bulk monoclinic structure.\textsuperscript{25} The crystal field (CF) split energy ratios were calculated based on the bulk crystal structure, and the overall CF splitting energy was used as a variable scaling parameter to fit the experimental XAS spectra. The one-electron energy level for Hf 5d\textsuperscript{0} \rightarrow 5d\textsuperscript{1} (empty bars in Fig. 2) is analyzed to be composed of five nondegenerate states: \( 2D(\gamma^2, \gamma^2, -\gamma^2, \gamma^2) \), \( 2S(3\gamma^2-\gamma^2) \), and two mixed states in the increasing order of energy. (Here the coordinate is taken as in Fig. 2.) The intensities of the five \( d \) levels are multiplied by the Hf 5d-O 2p hybridization strength using the Harrison’s rule (exponent \(-7\) for different interatomic distances)\textsuperscript{26} for the local structure as shown in the figure. The hybridization strength was found to exhibit an anisotropy; the in-planar \( 2D \) state has much weaker hybridization strength than the other levels (\( \sim 20\% \) of \( 2S \) and \( 2P \)). The \( 5d^1 \rightarrow 5d^2 \) simulation (filled bars) shows the similar results, except an overall broadening of features due to the atomic multiplets in the \( d^2 \) final state.\textsuperscript{27} The spectra simulated with the overall CF energy of approximately 4 eV, agree with the experimental spectrum and with the calculated Hf 5d PDOS (Ref. 1) shown in Fig. 1.

A slight difference in the XAS spectra of the oxygen-deficient film from the stoichiometric film can be seen in the features near the band gap as shown in Fig. 3. For comparison, we appended the XAS spectrum of the stoichiometric HfO\textsubscript{2} film measured under the same conditions. Both spectra were normalized approximately preserving the total absorp-
The CB tail state.23 and XAS spectra were arbitrarily chosen to be approximately in the middle of the chemical potentials of the stoichiometric HfO$_2$. The UPS spectrum for HfO$_{1.8}$ is taken from Ref. 32. Here, the position of the chemical potentials (zero energy in the figure) for both UPS and XAS spectra were arbitrarily chosen to be approximately in the middle of the band gap, preserving the band gap of bulk HfO$_2$ ($\sim$5.7 eV). Dotted lines show the extrapolations to obtain the approximate energy positions (arrows) of the CB and VB edges, and the shaded area indicates the contributions of the Si substrate or the interface state.

The spectrum of oxygen-deficient film appears broader than that of the stoichiometric one. We checked the broadness for many measurement points on each sample and found the consistency for each sample. Thus, the broadness can be regarded as an intrinsic property of the oxygen-deficient film. Though no prominent gap state is observed in the XAS spectrum of the oxygen-deficient film, the CB edge extends toward the band gap as compared to the stoichiometric one. This can be interpreted as the partial delocalization of the defect state; that is, the defect state might be rather dispersed so that it can also be detected at the oxygen site. Thus, the role of the oxygen vacancy can be regarded as donating electrons back to the Hf site and consequently to the Si substrate.28 Because the virtual transition to CB becomes easier.23

Influence of Oxygen Vacancies on the DOS, we also performed ultraviolet photoemission spectroscopy (UPS) using He-I ($h\nu$=21.2 eV) light source for both the films. (The UPS spectrum for HfO$_{1.8}$ is taken from Ref. 32.) The UPS spectra are also normalized with respect to the total intensity. Here, the energy zero is arbitrarily chosen to approximately sustain the energy difference between the lowest XAS edge ($\sim$+2.5 eV) and the highest UPS main feature ($\sim$3 eV) to be the known band gap of HfO$_2$ ($\sim$5.7 eV; Ref. 33). The UPS spectrum of HfO$_{1.8}$ film is shifted by +0.3 eV in order to compensate for the $E_F$ shift in the oxide, which was obtained from the cutoff kinetic energies of the secondary electrons in the spectra (not shown here);32 this $E_F$ shift induces the higher binding energy (BE) shift in the photoemission spectra, because the BE is, by definition, the energy difference between the Fermi level and the core level, while XAS is independent of the $E_F$ position because the energy difference between the initial core level and the final conduction level is independent of the Fermi level. The large and broad features around the relative energy of $\sim$−8−−4 eV correspond to the main O 2p level. The large and broad features around the relative energy of $\sim$−3 eV in Fig. 3 probably originates from the underlying Si wafer,34 because this VB tail is absent in the UPS spectra of thicker (>100 Å) HfO$_2$ film (not shown here). A slight increase in the tail in the oxygen deficient film might be a signature of the metallic Hf silicide (Hf-Si bond) at the interface.35 However, the VB edge of the oxygen-deficient film does not extend inside the band gap as compared with that of the stoichiometric sample. Though it is difficult to unambiguously analyze these band-tail states in both the occupied and unoccupied DOSs, we can observe that only the unoccupied DOS near the band gap tends to extend inside the band gap in the presence of oxygen vacancy.10,21 This result should be correlated with the lifting of Fermi level because the virtual transition to CB becomes easier.

Up to this point, we have shown experimental evidence that the oxygen vacancy lowers the CB edge and increases the effective Fermi level. The detailed mechanism explaining how the vacancy formation lowers the CB edge could be revealed by a further consideration of the atomic rearrangements or the relaxation following the vacancy formation. For example, the disorder in the positions of the vacant sites can play a role in broadening the CB DOS and consequently in reducing the band gap. Further, the energy position of the defect level is found to depend on the atomic arrangements after the vacancy formation. The reduction in the mean Hf-O bond length ($\sim$0.1 Å) and in the number of bonds, in the presence of oxygen vacancy,24 will influence the detailed balance in the charge dynamics between the two atomic species. The CB lowering can also be correlated with the broadening of features influenced by the valence configurations (the number of electrons) of the remaining atoms, as shown in the simulation results in Fig. 5. Further investigation is required to completely understand the mechanism.
magnetic coercivity field of the HfO$_2$ film. The difference spectrum or MCD has no feature, indicating no long-range ferromagnetic spin order. One could argue that the density of the oxygen vacancy is too small to detect FM; however, the value of 10% is larger than the dopant density in conventional diluted magnetic semiconductors (DMS).

To analyze the spectral features, we appended in Fig. 4(b) the simulation result obtained by the full atomic multiplet calculation for the Hf N$_3$-edge XAS (4p$_{3/2}\rightarrow 5d$) with the parameters similar to that of the O K-edge XAS, except for the 4p-5d Coulomb interactions. As was the case in the O K-edge XAS simulation, the simulated spectra are obtained by the sum of two transitions, 5d$^0\rightarrow 4p^55d^1$ and 5d$^1\rightarrow 4p^55d^2$. The features of the latter are shifted by $-2 \text{ eV}$ with respect to those of the former. The result of the calculation is in excellent agreement with the experimental spectra; therefore, it provides definite peak assignments: the Hf 4p$_{3/2}\rightarrow 5d$ transition is the largest feature, while the other features in the higher photon energies are attributed to the Hf 4p$_{3/2}\rightarrow 6sp$ transition. Contrary to 2p$\rightarrow 3d$ transition (as in the case of transition metal ions), the feature of the Hf 4p$\rightarrow 5d$ transition is not much stronger than 4p$\rightarrow 6sp$, because of its lower photoabsorption cross sections. The features of Hf 6sp for both the edges are denoted by $\nabla$ in Figs. 2 and 4. The peak positions almost coincide, confirming our peak assignments. The simulated MCD signal for Hf 5d [Fig. 4(b)] is small due to the small anisotropy in the unoccupied electron states $(d^8-9)$. Although the sensitivity of the MCD measurement on magnetism is low, no correlation was observed between the experimental and simulated MCD spectra. This confirms that the small modulation in the experimental spectrum is caused by the noise, not the possible long-range magnetism.

Therefore, we can conclude that there is no preference in spin selection in the electron occupation to either Hf 5d or 6sp; this evidently proves “no ferromagnetic spin order” in the case of oxygen vacancy. However, the electron occupation number at an Hf site should be nonzero; otherwise, the electronic configurations of the next nearest O sites, which was shown in the O K-edge XAS spectra (Fig. 3), should never be influenced by the presence of oxygen vacancy. Thus, the absence of FM spin order can be explained by the absence of long-range correlation between the d electrons in the neighboring Hf sites, rather than the absence of the $d$ electron itself.

IV. CONCLUSION

We conclude our arguments with two remarks: the oxygen vacancy in the Hf oxide slightly enhances the CB DOS. However, it does not involve the long-range ferromagnetic spin order in the oxide because of the absence of intersite electron correlation.

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Here the effect of charges generated by the oxygen vacancy is neglected, so that the overall CF splitting energy is assumed to be independent of the number of d electrons.


Here the Slater integrals for Hf\(^{3+}\)(d\(^{3}\))/Hf\(^{2+}\)(d\(^{2}\)) final states were taken as the reduced values by less than one-half from those calculated for Hf\(^{3+}\)/Hf\(^{2+}\) ion by using Cowan’s code for Hartree-Fock method: for Hf\(^{3+}\)(d\(^{3}\)), \(F_{pd}=9.447\), \(G_{pd}=2.187\), and \(G_{pd}^{d}=2.399\) in eV; and for Hf\(^{2+}\)(d\(^{2}\)), \(F_{pd}^{d}=13.102\), \(F_{pd}^{d}=9.086\), \(F_{pd}^{d}=9.332\), \(F_{pd}^{d}=2.239\) in eV; and for Hf\(^{2+}\)(d\(^{2}\)), \(F_{pd}^{d}=13.102\), \(F_{pd}^{d}=9.086\), \(F_{pd}^{d}=9.332\), \(F_{pd}^{d}=2.239\) in eV. Hubbard \(U\) and \(F_{pd}^{d}\) were set to 2 eV and 4 eV, respectively, and the 5d spin-orbit coupling constant was set to about 0.1 eV throughout the calculation. For more details of the calculational method, refer to R. D. Cowan, *The Theory of Atomic Structure and Spectra* (University of California Press, California, 1981).